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Application/Control No.	Applicant(s)/Patent under Reexamination
10/736,326	GOIKE ET AL.
Examiner	Art Unit
Vuthe Siek	2825

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INTERFERENCE SEARCHED				
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	SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
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EAST (ALL DATABASES) & IEEE (TEXT SEARCH ONLY) (SEE SEARCH HISTORY PRINTOUTS))	8/15/2005	VS		
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